

Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/630,948	HANG, WEI ZHAN
	Examiner	Art Unit
	Phi D. A	3637

SEARCHED			
Class	Subclass	Date	Examiner
52	506.08	8/31/2007	PA
	509		
	510		
	506.09		
	506.1		
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	545		
	506.06		
	506.07		
403	314		
	218		
248	322*		
	339*		
	343*		